# MOSFET - Power, Complementary, WDFN 2X2 mm 20 V/-20 V, 4.6 A/-4.1 A

### **Features**

- Complementary N-Channel and P-Channel MOSFET
- WDFN Package with Exposed Drain Pad for Excellent Thermal Conduction
- Footprint Same as SC-88 Package
- Leading Edge Trench Technology for Low On Resistance
- 1.8 V Gate Threshold Voltage
- Low Profile (< 0.8 mm) for Easy Fit in Thin Environments
- This is a Pb-Free Device

### **Applications**

- Synchronous DC-DC Conversion Circuits
- Load/Power Management of Portable Devices like PDA's, Cellular Phones and Hard Drives
- Color Display and Camera Flash Regulators

## **MAXIMUM RATINGS** (T<sub>J</sub> = 25°C unless otherwise noted)

Parar	Symbol	Value	Unit			
Drain-to-Source Volta	N-Ch	$V_{DSS}$	20	V		
	P-Ch		-20			
Gate-to-Source Voltag	je	N-Ch	$V_{GS}$	±8.0	V	
		P-Ch				
N-Channel	Steady	T <sub>A</sub> = 25°C	$I_{D}$	3.8	Α	
Continuous Drain Current (Note 1)	State	T <sub>A</sub> = 85°C		2.8		
Current (Note 1)	t≤5 s	$T_A = 25^{\circ}C$		4.6		
P-Channel	Steady	T <sub>A</sub> = 25°C	$I_{D}$	-3.3	Α	
Continuous Drain Current (Note 1)	State	T <sub>A</sub> = 85°C		-2.4		
Current (Note 1)	t≤5s	$T_A = 25^{\circ}C$		-4.1		
Power Dissipation	Steady		$P_{D}$	1.5	W	
(Note 1)	State	T <sub>A</sub> = 25°C				
	t≤5s			2.3		
N-Channel Continuous Drain	Steady	T <sub>A</sub> = 25°C	$I_{D}$	2.6	Α	
Current (Note 2)	State	T <sub>A</sub> = 85°C		1.9		
P-Channel	Steady	T <sub>A</sub> = 25°C	$I_{D}$	-2.3	Α	
Continuous Drain Current (Note 2)	State	T <sub>A</sub> = 85°C		-1.6		
Power Dissipation (Note 2)	Steady State	T <sub>A</sub> = 25°C	$P_{D}$	0.71	W	
Pulsed Drain Current	N-Ch	t <sub>p</sub> = 10 μs	I <sub>DM</sub>	18	Α	
	P-Ch	1		-20		
Operating Junction and	T <sub>J</sub> , T <sub>STG</sub>	–55 to 150	°C			
Lead Temperature for 9 (1/8" from case for 10 s	TL	260	°C			

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1



## ON Semiconductor®

### www.onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> MAX	I <sub>D</sub> MAX
N-Channel 20 V	65 m $\Omega$ @ 4.5 V	3.8 A
	85 m $\Omega$ @ 2.5 V	2.0 A
	120 mΩ @ 1.8 V	1.7 A
D. Obsessed	100 mΩ @ –4.5 V	-4.1 A
P-Channel -20 V	135 mΩ @ –2.5 V	-2.0 A
	200 mΩ @ –1.8 V	-1.6 A

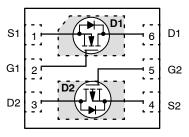
# D2 D1 MARKING DIAGRAM WDFN6 CASE 506AN MARKING DIAGRAM JM M

JM = Specific Device Code M = Date Code

= Pb-Free Package

(Note: Microdot may be in either location)

### **PIN CONNECTIONS**



(Top View)

### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NTLJD3119CTAG	WDFN6 (Pb-Free)	3000/Tape & Reel
NTLJD3119CTBG	WDFN6 (Pb-Free)	3000/Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

NTLJD3119C	
<ol> <li>Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.127 in sq [2 oz] including traces).</li> <li>Surface Mounted on FR4 Board using the minimum recommended pad size of 30 mm<sup>2</sup>, 2 oz Cu.</li> </ol>	

## THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Unit
SINGLE OPERATION (SELF-HEATED)			•
Junction-to-Ambient - Steady State (Note 3)	$R_{ hetaJA}$	83	
Junction-to-Ambient - Steady State Min Pad (Note 4)	$R_{ hetaJA}$	177	°C/W
Junction-to-Ambient - t ≤ 5 s (Note 3)	$R_{ hetaJA}$	54	
DUAL OPERATION (EQUALLY HEATED)			
Junction-to-Ambient - Steady State (Note 3)	$R_{ hetaJA}$	58	
Junction-to-Ambient - Steady State Min Pad (Note 4)	$R_{ heta JA}$	133	°C/W
Junction-to-Ambient – t ≤ 5 s (Note 3)	$R_{ heta JA}$	40	

Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.127 in sq [2 oz] including traces).
 Surface Mounted on FR4 Board using the minimum recommended pad size (30 mm², 2 oz Cu).

## **ELECTRICAL CHARACTERISTICS** (T<sub>1</sub> = 25°C unless otherwise noted)

Parameter	Symbol	N/P	Test Conditions			Тур	Max	Unit
OFF CHARACTERISTICS		14/1	rest conditions			.,,,,	Max	0
Drain-to-Source Breakdown Voltage	V(DD) D00	N		I <sub>D</sub> = 250 μA	20			V
Diam-to-Source Dreakdown Voltage	V <sub>(BR)DSS</sub>	P	V <sub>GS</sub> = 0 V	I <sub>D</sub> = -250 μA	-20			, v
Drain to Course Breekdown Veltore	V /T			I <sub>D</sub> = -250 μA	-20	10.4		m)//ºC
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>	N				10.4		mV/°C
		Р		T		9.95		
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	N	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 16 V	T <sub>.1</sub> = 25 °C			1.0	μΑ
		Р	$V_{GS} = 0 \text{ V}, V_{DS} = -16 \text{ V}$	Ü			-1.0	
		N	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 16 V	T <sub>J</sub> = 85 °C			10	
		Р	$V_{GS} = 0 \text{ V}, V_{DS} = -16 \text{ V}$	.,			-10	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	N	$V_{DS} = 0 V, V_{GS} =$	±8.0 V			±100	nA
		Р	$V_{DS} = 0 V, V_{GS} =$	±8.0 V			±100	
ON CHARACTERISTICS (Note 5)								
Gate Threshold Voltage	V <sub>GS(TH)</sub>	N	., .,	I <sub>D</sub> = 250 μA	0.4	0.7	1.0	V
		Р	$V_{GS} = V_{DS}$	I <sub>D</sub> = -250 μA	-0.4	-0.7	-1.0	
Gate Threshold Temperature	V <sub>GS(TH)</sub> /T <sub>J</sub>	N				-3.0		mV/°C
Coefficient		Р				2.44		
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	N	V <sub>GS</sub> = 4.5 V , I <sub>D</sub> = 3.8 A			37	65	mΩ
		Р	$V_{GS} = -4.5 \text{ V}$ , $I_D = -4.1 \text{ A}$			75	100	
		N	V <sub>GS</sub> = 2.5 V , I <sub>D</sub> = 2.0 A			46	85	
		P	V <sub>GS</sub> = -2.5 V, I <sub>D</sub> = -2.0 A			101	135	
		N		$V_{GS} = 1.8 \text{ V}, I_{D} = 1.7 \text{ A}$ $V_{GS} = -1.8 \text{ V}, I_{D} = -1.6 \text{ A}$		65	120	
		P				150	200	
Forward Transconductance	9FS	N	V <sub>DS</sub> = 10 V, I <sub>D</sub> =			4.2		S
Torward Transconductance	95	P	$V_{DS} = -5.0 \text{ V}, I_{D} =$			3.1		
CHARGES, CAPACITANCES AND GA	ATE DECICEA		VDS = -3.0 V , ID =	= -2.0 A		3.1		
·	1		Ī	V 40.V	I	074	I	
Input Capacitance	C <sub>ISS</sub>	N		V <sub>DS</sub> = 10 V		271		pF
	_	Р		V <sub>DS</sub> = -10 V		531		
Output Capacitance	C <sub>OSS</sub>	N	f = 1.0 MHz, V <sub>GS</sub> = 0 V	V <sub>DS</sub> = 10 V		72		
		Р	, 40	V <sub>DS</sub> = -10 V		91		
Reverse Transfer Capacitance	C <sub>RSS</sub>	N		V <sub>DS</sub> = 10 V		43		
		Р		V <sub>DS</sub> = -10 V		56		
Total Gate Charge	$Q_{G(TOT)}$	N	$V_{GS} = 4.5 \text{ V}, V_{DS} = 10 \text{ V}, I_D = 3.8 \text{ A}$			3.7		nC
		Р	$V_{GS} = -4.5 \text{ V}, V_{DS} = -10 \text{ V}, I_D = -2.0 \text{ A}$			5.5		
Threshold Gate Charge	Q <sub>G(TH)</sub>	N	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 10 V, I <sub>D</sub> = 3.8 A			0.3		
		Р	$V_{GS} = -4.5 \text{ V}, V_{DS} = -10 \text{ V}, I_D = -2.0 \text{ A}$			0.7		
Gate-to-Source Charge	Q <sub>GS</sub>	N	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 10	V, I <sub>D</sub> = 3.8 A		0.6		
<b>5</b> -		Р	V <sub>GS</sub> = -4.5 V, V <sub>DS</sub> = -10	V, I <sub>D</sub> = -2.0 A		1.0		
	1	1			<del></del>	ļ		
Gate-to-Drain Charge	$Q_{GD}$	N	$V_{GS} = 4.5 \text{ V}, V_{DS} = 10^{\circ}$	V, I <sub>D</sub> = 3.8 A		1.0		

# **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise noted)

Parameter	Symbol	N/P	Test Condition	ons	Min	Тур	Max	Unit
SWITCHING CHARACTERISTIC	S (Note 6)				•	•		
Turn-On Delay Time	t <sub>d(ON)</sub>					3.8		ns
Rise Time	t <sub>r</sub>	N	$V_{GS}$ = 4.5 V, $V_{DD}$ = 16 V, $I_{D}$ = 1.0 A, $R_{G}$ = 2.0 $\Omega$			4.7		
Turn-Off Delay Time	t <sub>d(OFF)</sub>					11.1		
Fall Time	t <sub>f</sub>					5.8		
Turn-On Delay Time	t <sub>d(ON)</sub>		$V_{GS} = -4.5 \text{ V}, V_{DD} = -10 \text{ V},$ $I_{D} = -2.0 \text{ A}, R_{G} = 2.0 \Omega$			5.2		
Rise Time	t <sub>r</sub>	P				13.2		
Turn-Off Delay Time	t <sub>d(OFF)</sub>					13.7		
Fall Time	t <sub>f</sub>					19.1		
DRAIN-SOURCE DIODE CHAR	ACTERISTICS				-			
Forward Diode Voltage	$V_{SD}$	N	V0V T 25 °C	I <sub>S</sub> = 1.0 A		0.69	1.0	V
		Р	$V_{GS} = 0 \text{ V}, T_J = 25 ^{\circ}\text{C}$	I <sub>S</sub> = -1.0 A		-0.75	-1.0	
		N	V 0VT 105°C	I <sub>S</sub> = 1.0 A		0.52		
		Р	V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C	I <sub>S</sub> = -1.0 A		-0.64		
Reverse Recovery Time	t <sub>RR</sub>	N		I <sub>S</sub> = 1.0 A		10.2		ns
		Р		I <sub>S</sub> = -1.0 A		16.2		
Charge Time	t <sub>a</sub>	N	I <sub>S</sub> = 1.0 A			6.0		
		Р	$\frac{P}{N}$ $V_{GS} = 0 \text{ V},$ $I_S = -1.0 \text{ A}$ $I_S = 1.0 \text{ A}$	I <sub>S</sub> = -1.0 A		10.6		
Discharge Time	t <sub>b</sub>	N		I <sub>S</sub> = 1.0 A		4.2		
		Р		I <sub>S</sub> = -1.0 A		5.6		
Reverse Recovery Charge	Q <sub>RR</sub>	N		I <sub>S</sub> = 1.0 A				nC
	I				+	<del> </del>		

5.7

 $I_S = -1.0 A$ 

<sup>5.</sup> Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
6. Switching characteristics are independent of operating junction temperatures.

# $\textbf{TYPICAL PERFORMANCE CURVES - N-CHANNEL} \ (T_J = 25^{\circ}\text{C unless otherwise noted})$

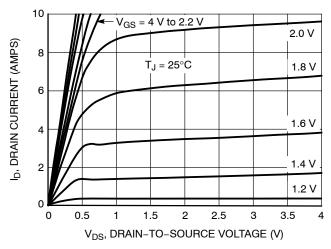


Figure 1. On-Region Characteristics

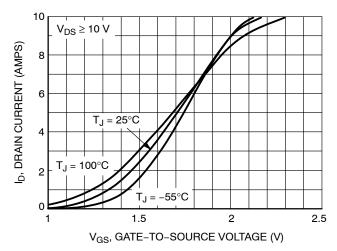


Figure 2. Transfer Characteristics

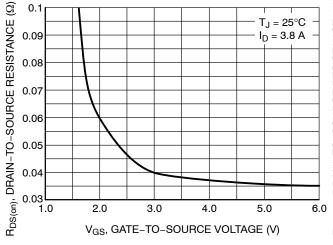


Figure 3. On-Resistance versus Drain Current

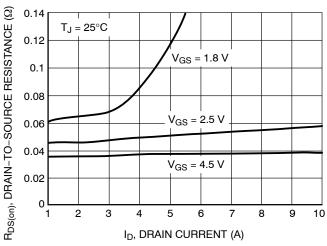


Figure 4. On-Resistance versus Drain Current and Gate Voltage

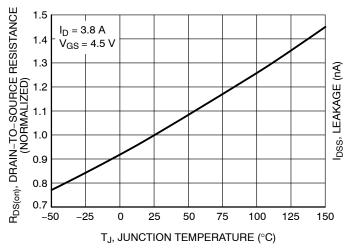


Figure 5. On–Resistance Variation with Temperature

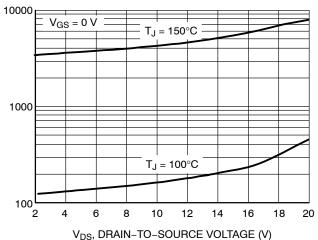
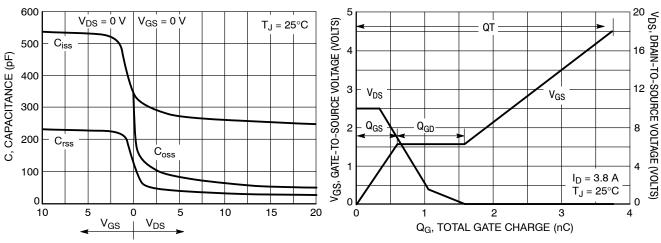


Figure 6. Drain-to-Source Leakage Current versus Voltage

## TYPICAL PERFORMANCE CURVES - N-CHANNEL (T<sub>J</sub> = 25°C unless otherwise noted)



GATE-TO-SOURCE OR DRAIN-TO-SOURCE VOLTAGE (V)

Figure 7. Capacitance Variation

Figure 8. Gate-To-Source and Drain-To-Source Voltage versus Total Charge

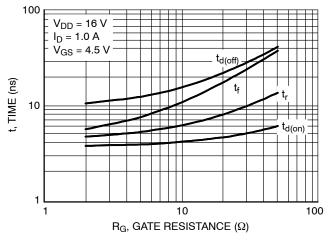


Figure 9. Resistive Switching Time Variation versus Gate Resistance

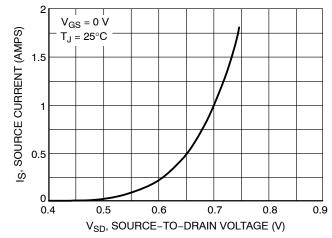


Figure 10. Diode Forward Voltage versus Current

## TYPICAL PERFORMANCE CURVES - P-CHANNEL (T<sub>J</sub> = 25°C unless otherwise noted)

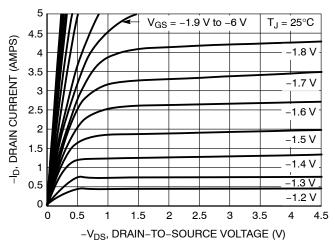
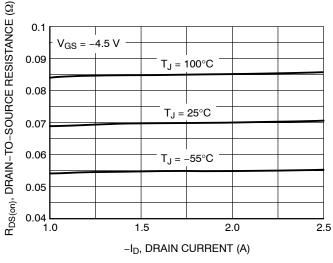


Figure 11. On-Region Characteristics

Figure 12. Transfer Characteristics



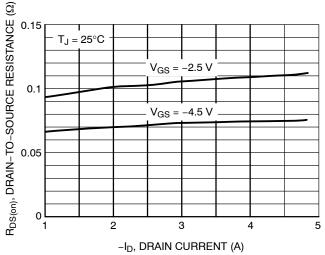
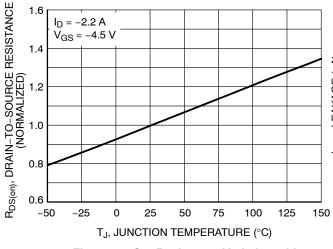


Figure 13. On-Resistance versus Drain Current

Figure 14. On-Resistance versus Drain Current and Gate Voltage



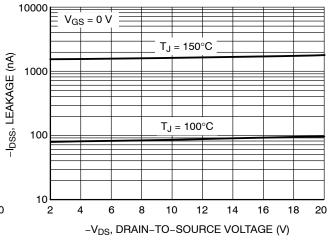
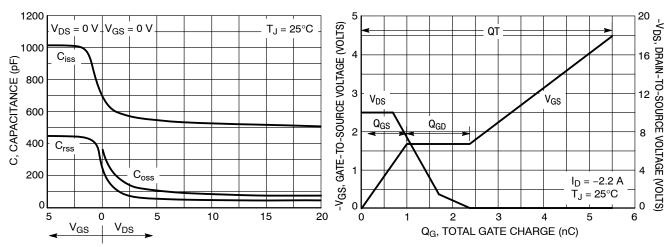


Figure 15. On–Resistance Variation with Temperature

Figure 16. Drain-to-Source Leakage Current versus Voltage

# TYPICAL PERFORMANCE CURVES – P-CHANNEL ( $T_J = 25^{\circ}C$ unless otherwise noted)



GATE-TO-SOURCE OR DRAIN-TO-SOURCE VOLTAGE (V)

Figure 17. Capacitance Variation

Figure 18. Gate-To-Source and Drain-To-Source
Voltage versus Total Charge

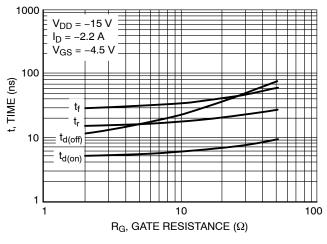


Figure 19. Resistive Switching Time Variation versus Gate Resistance

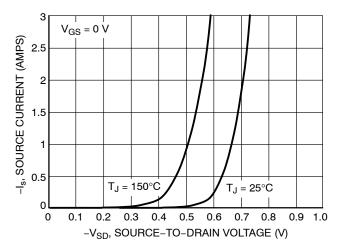


Figure 20. Diode Forward Voltage versus Current

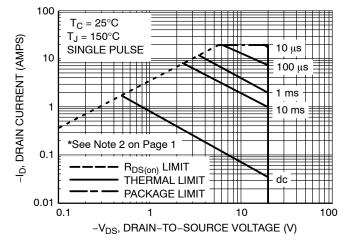


Figure 21. Maximum Rated Forward Biased Safe Operating Area

# TYPICAL PERFORMANCE CURVES ( $T_J = 25^{\circ}$ C unless otherwise noted)

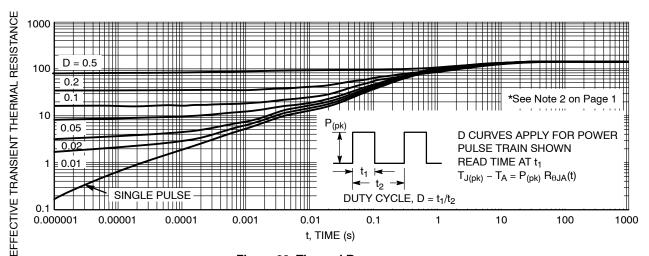
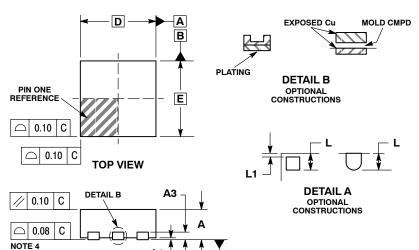


Figure 22. Thermal Response



## WDFN6 2x2, 0.65P CASE 506AN **ISSUE G**

**DATE 22 AUG 2013** 



SEATING PLANE C

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M. 1994.
- CONTROLLING DIMENSION: MILLIMETERS.
  DIMENSION & APPLIES TO PLATED
- TERMINAL AND IS MEASURED BETWEEN
- 0.15 AND 0.30 mm FROM THE TERMINAL TIP. COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.

	MILLIMETERS						
DIM	MIN	MAX					
Α	0.70	0.80					
A1	0.00	0.05					
A3	0.20	REF					
b	0.25	0.35					
D	2.00	BSC					
D2	0.57	0.77					
E	2.00	BSC					
E2	0.90	1.10					
е	0.65	BSC					
F	0.95 BSC						
K	0.25	REF					
L	0.20	0.30					
L1	-	0.10					

## **GENERIC MARKING DIAGRAM\***



XX = Specific Device Code

М = Date Code

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■", may or may not be present.

#### D2 D2 F DETAIL A ⊕ 0.10 C A Κ ex b 0.10 С Α В е Ф 0.05 С NOTE 3 **BOTTOM VIEW**

**A1** 

⊕ 0.10 C A

**SIDE VIEW** 

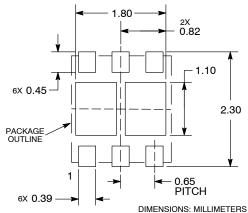
#### STYLE 1: SOURCE 1 GATE 1 2.

- DRAIN 2 SOURCE 2
- 5. GATE 2 6. DRAIN 1
- STYLE 2: PIN 1. 2.
  - ANODE N/C 3.
  - DRAIN SOURCE GATE

CATHODE

- STYLE 3: SOURCE 1 GATE 1 2. 3. SOURCE 2
  - DRAIN 2 5. GATE 2 DRAIN 1 6.

## **SOLDERMASK DEFINED** MOUNTING FOOTPRINT



DOCUMENT NUMBER:	98AON20861D	Electronic versions are uncontrolled except when accessed directly from the Document Reposit Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.			
DESCRIPTION:	WDFN6 2X2, 0.65P		PAGE 1 OF 1		

ON Semiconductor and (III) are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. ON Semiconductor does not convey any license under its patent rights nor the rights of others.

onsemi, ONSEMI, and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries. onsemi owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of onsemi's product/patent coverage may be accessed at <a href="www.onsemi.com/site/pdf/Patent-Marking.pdf">www.onsemi.com/site/pdf/Patent-Marking.pdf</a>. Onsemi reserves the right to make changes at any time to any products or information herein, without notice. The information herein is provided "as-is" and onsemi makes no warranty, representation or guarantee regarding the accuracy of the information, product features, availability, functionality, or suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using onsemi products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications provided by onsemi. "Typical" parameters which may be provided in onsemi data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. onsemi does not convey any license under any of its intellectual property rights nor the rights of others. onsemi products are not designed, intended, or authorized for use as a critical component in life support systems or any EDA class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer pu

#### **PUBLICATION ORDERING INFORMATION**

LITERATURE FULFILLMENT:
Email Requests to: orderlit@onsemi.com

onsemi Website: www.onsemi.com

TECHNICAL SUPPORT North American Technical Support: Voice Mail: 1 800-282-9855 Toll Free USA/Canada Phone: 011 421 33 790 2910

Europe, Middle East and Africa Technical Support:

a Phone: 00421 33 790 2910

For additional information, please contact your local Sales Representative

# **X-ON Electronics**

Largest Supplier of Electrical and Electronic Components

Click to view similar products for MOSFET category:

Click to view products by ON Semiconductor manufacturer:

Other Similar products are found below:

614233C 648584F IRFD120 JANTX2N5237 FCA20N60\_F109 FDZ595PZ 2SK2545(Q,T) 405094E 423220D TPCC8103,L1Q(CM MIC4420CM-TR VN1206L SBVS138LT1G 614234A 715780A NTNS3166NZT5G SSM6J414TU,LF(T 751625C BUK954R8-60E NTE6400 SQJ402EP-T1-GE3 2SK2614(TE16L1,Q) 2N7002KW-FAI DMN1017UCP3-7 EFC2J004NUZTDG ECH8691-TL-W FCAB21350L1 P85W28HP2F-7071 DMN1053UCP4-7 NTE221 NTE222 NTE2384 NTE2903 NTE2941 NTE2945 NTE2946 NTE2960 NTE2967 NTE2969 NTE2976 NTE455 NTE6400A NTE2910 NTE2916 NTE2956 NTE2911 DMN2080UCB4-7 TK10A80W,S4X(S SSM6P69NU,LF DMP22D4UFO-7B